Notice of References Cited Application/Control No. 10/701,760 Examiner Sang Nguyen Applicant(s)/Patent Under Reexamination WIDEN, KENNETH C. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,193,693	03-2007	Yazaki et al.	356/30
*	В	US-7,128,737	10-2006	Goder et al.	606/10
*	С	US-6,606,158	08-2003	Rosenfeldt et al.	356/477
*	D	US-6,549,092	04-2003	Hattori et al.	333/134
*	E	US-6,044,329	03-2000	Kidd, Gary	702/28
*	F	US-5,124,993	06-1992	Braunlich et al.	372/31
*	G	US-5,100,231	03-1992	Sasnett et al.	356/121
*	Н	US-5,078,491	01-1992	Johnston, Jr., Thomas F.	356/121
*	1	US-4,910,690	03-1990	Fujita, Hiroo	702/159
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.